

**MOTOROLA**  
**SEMICONDUCTOR**  
 TECHNICAL DATA

*Designer's Data Sheet*  
**Power Field Effect Transistor**  
**P-Channel Enhancement-Mode**  
**Silicon Gate**

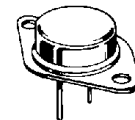
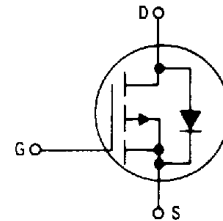
This TMOS Power FET is designed for medium voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds — Switching Times Specified at 100°C
- Designer's Data —  $I_{DSS}$ ,  $V_{DS(on)}$ ,  $V_{GS(th)}$  and SOA Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads



**MTM20P10**

TMOS POWER FET  
 20 AMPERES  
 $R_{DS(on)} = 0.15 \text{ OHM}$   
 100 VOLTS



CASE 1-07  
 TO-204AA

**MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	100	Vdc
Drain-Gate Voltage ( $R_{GS} = 1 \text{ M}\Omega$ )	$V_{DGR}$	100	Vdc
Gate-Source Voltage Continuous	$V_{GS}$	$\pm 20$	Vdc
Non-repetitive ( $t_p \leq 50 \mu s$ )	$V_{GSM}$	$\pm 40$	Vpk
Drain Current Continuous	$I_D$	20	Adc
Pulsed	$I_{DM}$	80	
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	$P_D$	125 1	Watts W/°C
Operating and Storage Temperature Range	$T_J, T_{stg}$	-65 to 150	°C

**THERMAL CHARACTERISTICS**

Thermal Resistance Junction to Case	$R_{\theta JC}$	1	°C/W
Junction to Ambient	$R_{\theta JA}$	30	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	$T_L$	300	°C

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design

**ELECTRICAL CHARACTERISTICS** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
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**OFF CHARACTERISTICS**

Drain-Source Breakdown Voltage ( $V_{GS} = 0, I_D = 0.25 \text{ mA}$ )	$V_{(BR)DSS}$	100	—	Vdc
Zero Gate Voltage Drain Current ( $V_{DS} = \text{Rated } V_{DSS}, V_{GS} = 0$ ) ( $V_{DS} = \text{Rated } V_{DSS}, V_{GS} = 0, T_J = 125^\circ\text{C}$ )	$I_{DSS}$	—	10 100	$\mu\text{Adc}$
Gate-Body Leakage Current, Forward ( $V_{GSF} = 20 \text{ Vdc}, V_{DS} = 0$ )	$I_{GSSF}$	—	100	nAdc
Gate-Body Leakage Current, Reverse ( $V_{GSR} = 20 \text{ Vdc}, V_{DS} = 0$ )	$I_{GSSR}$	—	100	nAdc

**ON CHARACTERISTICS\***

Gate Threshold Voltage ( $V_{DS} = V_{GS}, I_D = 1 \text{ mA}$ ) $T_J = 100^\circ\text{C}$	$V_{GS(th)}$	2 1.5	4.5 4	Vdc
Static Drain-Source On-Resistance ( $V_{GS} = 10 \text{ Vdc}, I_D = 10 \text{ Adc}$ )	$R_{DS(on)}$	—	0.15	Ohm
Drain-Source On-Voltage ( $V_{GS} = 10 \text{ V}$ ) ( $I_D = 20 \text{ Adc}$ ) ( $I_D = 10 \text{ Adc}, T_J = 100^\circ\text{C}$ )	$V_{DS(on)}$	—	3.2 3	Vdc
Forward Transconductance ( $V_{DS} = 10 \text{ V}, I_D = 10 \text{ A}$ )	$g_{FS}$	5	—	mhos

**DYNAMIC CHARACTERISTICS**

Input Capacitance	( $V_{DS} = 25 \text{ V}, V_{GS} = 0,$ $f = 1 \text{ MHz}$ ) See Figure 10	$C_{iss}$	—	2000	pF
Output Capacitance		$C_{oss}$	—	950	
Reverse Transfer Capacitance		$C_{rss}$	—	400	

**SWITCHING CHARACTERISTICS\* ( $T_J = 100^\circ\text{C}$ )**

Turn-On Delay Time	( $V_{DD} = 25 \text{ V}, I_D = 0.5 \text{ Rated } I_D$ $R_{gen} = 50 \text{ ohms}$ ) See Figures 12 and 13	$t_{d(on)}$	—	45	ns
Rise Time		$t_r$	—	200	
Turn-Off Delay Time		$t_{d(off)}$	—	150	
Fall Time		$t_f$	—	150	
Total Gate Charge	( $V_{DS} = 0.8 \text{ Rated } V_{DSS},$ $I_D = \text{Rated } I_D, V_{GS} = 10 \text{ V}$ ) See Figure 11	$Q_g$	52 (Typ)	75	nC
Gate-Source Charge		$Q_{gs}$	22 (Typ)	—	
Gate-Drain Charge		$Q_{gd}$	30 (Typ)	—	

**SOURCE DRAIN DIODE CHARACTERISTICS\***

Forward On-Voltage	( $I_S = \text{Rated } I_D$ $V_{GS} = 0$ )	$V_{SD}$	2.8 (Typ)	4	Vdc
Forward Turn-On Time		$t_{on}$	100 (Typ)	—	ns
Reverse Recovery Time		$t_{rr}$	350 (Typ)	—	ns

\*Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

TYPICAL ELECTRICAL CHARACTERISTICS

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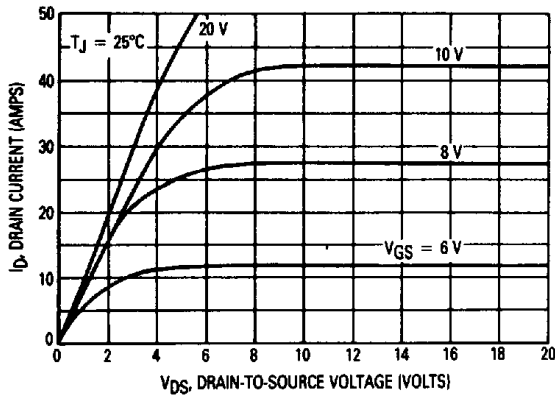


Figure 1. On-Region Characteristics

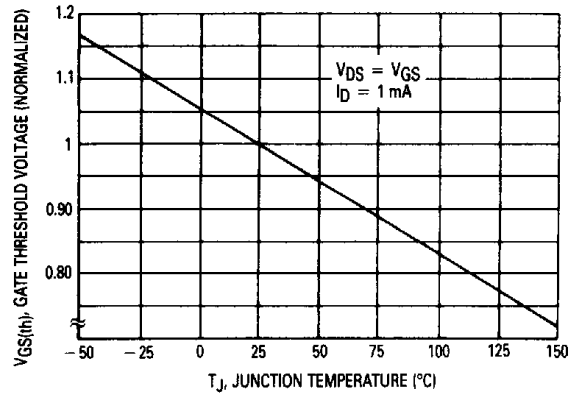


Figure 2. Gate-Threshold Voltage Variation With Temperature

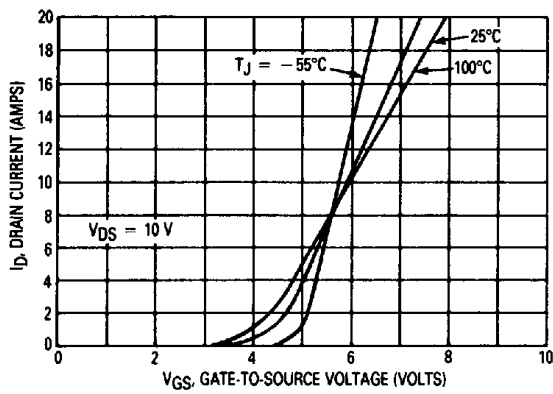


Figure 3. Transfer Characteristics

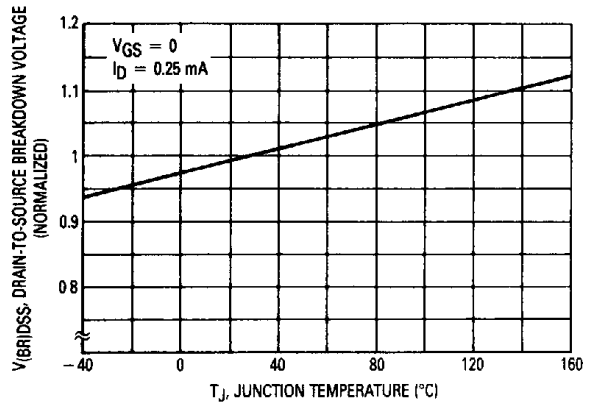


Figure 4. Breakdown Voltage Variation With Temperature

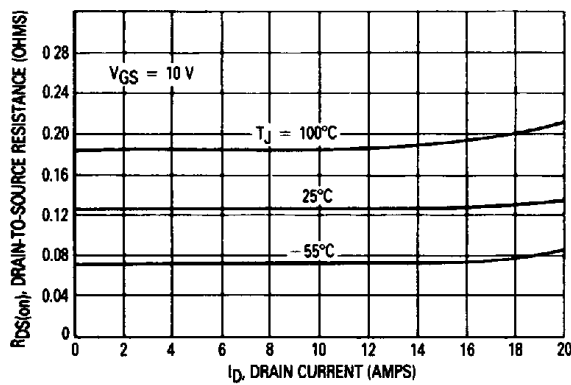


Figure 5. On-Resistance versus Drain Current

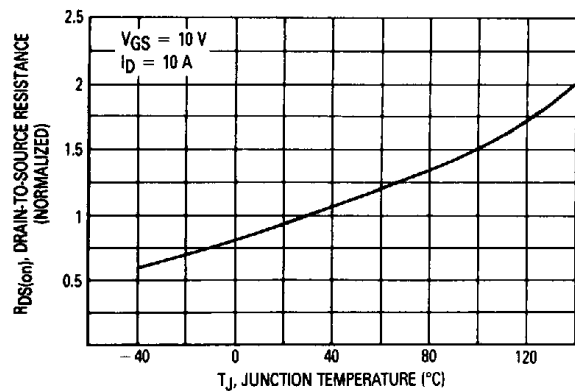


Figure 6. On-Resistance Variation With Temperature

SAFE OPERATING AREA INFORMATION

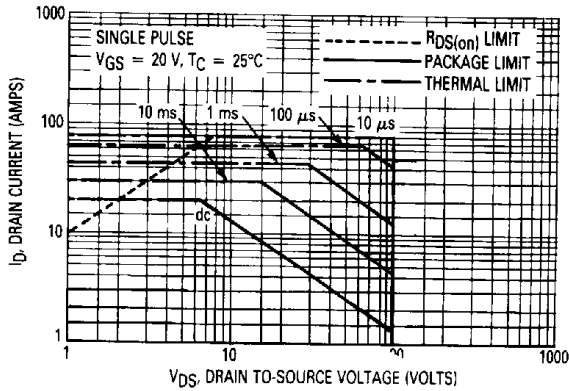


Figure 7. Maximum Rated Forward Biased Safe Operating Area

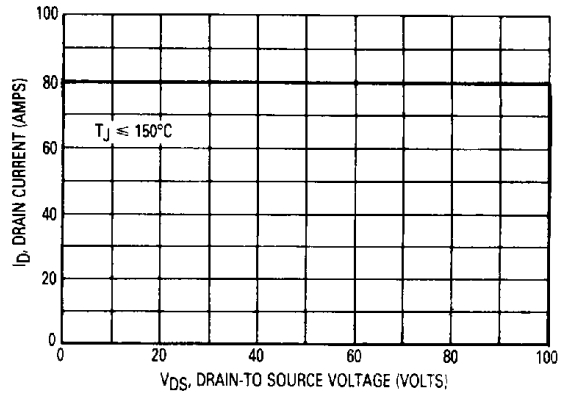


Figure 8. Maximum Rated Switching Safe Operating Area

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current,  $I_{DM}$  and the breakdown voltage,  $V_{(BR)DSS}$ . The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$

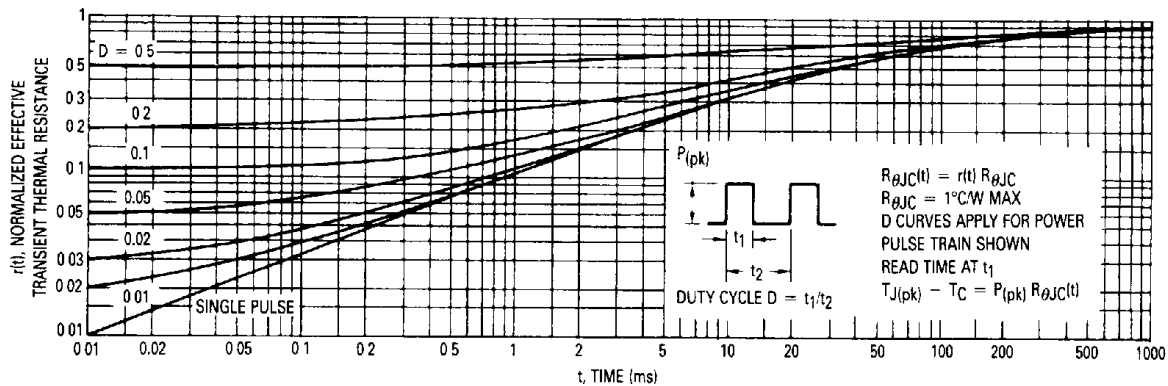


Figure 9. Thermal Response

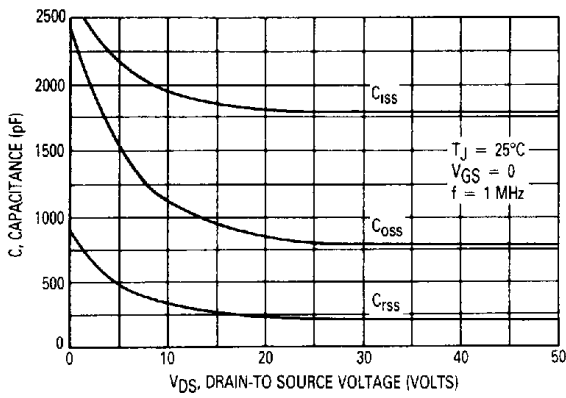


Figure 10. Capacitance Variation

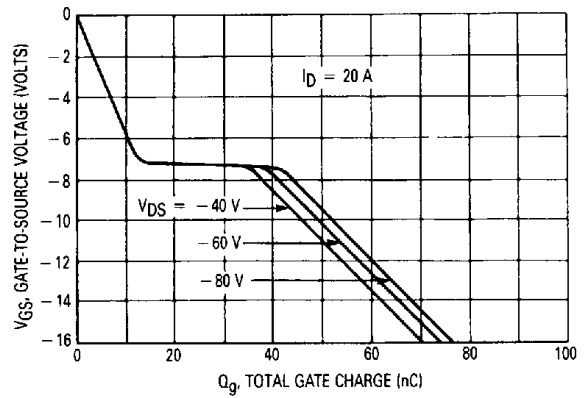


Figure 11. Gate Charge versus Gate-To-Source Voltage

RESISTIVE SWITCHING

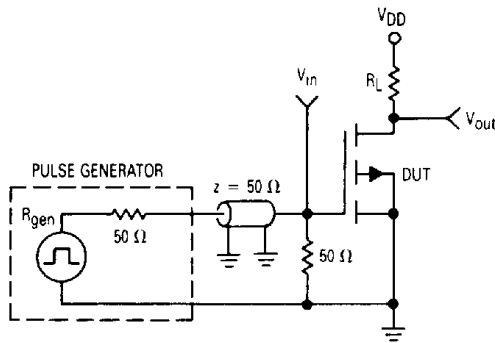


Figure 12. Switching Test Circuit

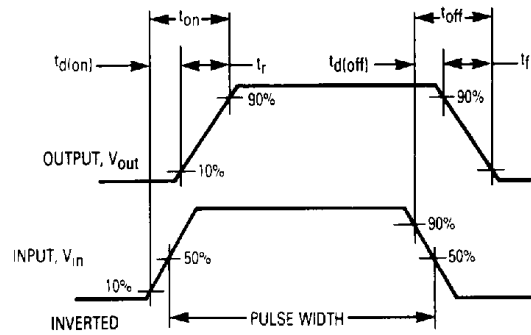


Figure 13. Switching Waveforms